

Notice of References Cited	Application/Control No. 10/561,528		Applicant(s)/Patent Under Reexamination TANIUCHI ET AL.	
	Examiner HENOK LEGESSE		Art Unit 2861	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,059,407 A	05-2000	Komatsu et al.	347/103
*	B	US-2004/0182270 A1	09-2004	Wiedemer et al.	101/465
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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